	Experimental	**Control**		**Standardised Mean**		
SMD	**SE(SMD)**	**Total**	**Total**	**Difference**	**SMD**	**95%**

SMD	SE(SMD)	Total	Total	SMD	95%
−2.1000	42.3627	16	16	−2.10	[−85.13; 8
−2.1000	51.0247	45	45	−2.10	[−102.11; 9
34.4160	60.4045	15	15	34.42	[−83.97; 15
11.9000	45.9200	42	42	11.90	[−78.10; 10
4.6512	43.8519	12	12	4.65	[−81.30; 9
−2.2000	44.1427	39	39	−2.20	[−88.72; 8
−4.0000	43.6005	16	16	−4.00	[−89.46; 8
−7.7400	41.8834	15	15	−7.74	[−89.83; 7
16.6300	35.0187	10	10	16.63	[−52.01; 8
6.0000	41.7253	13	13	6.00	[−75.78; 8
5.0000	38.0132	20	20	5.00	[−69.50; 7
ect model		**243**	**243**	**4.80**	**[−20.71; 3**

−150 −100 −50 0 50 100 150

$I^2 = 0\%$, $\tau^2 = 0$, $p = 1.00$